

STATIC RAM

IDT7014S

Features:

- True Dual-Ported memory cells which allow simultaneous reads of the same memory location
- High-speed access
 - Commercial: 12/15/20/25ns (max.)
 - Industrial: 20ns (max.)
- Standard-power operation
 - IDT7014S

Active: 750mW (typ.)

- Fully asynchronous operation from either port
- TTL-compatible; single 5V (±10%) power supply
- Available in 52-pin PLCC and a 64-pin TQFP
- Industrial temperature range (-40°C to +85°C) is available for selected speeds
- Green parts available, see ordering information

Description:

The IDT7014 is a high-speed 4K x 9 Dual-Port Static RAM designed to be used in systems where on-chip hardware port arbitration is not needed. This part lends itself to high-speed applications which do not rely on BUSY signals to manage simultaneous access.

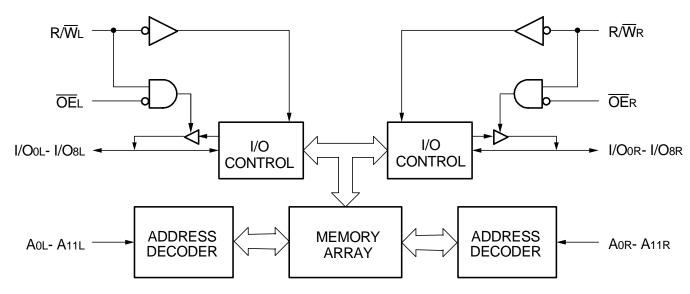
The IDT7014 provides two independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. See functional description.

The IDT7014 utilitizes a 9-bit wide data path to allow for parity at the user's option. This feature is especially useful in data communication applications where it is necessary to use a parity bit for transmission/ reception error checking.

Fabricated using a high-performance technology, these Dual-Ports typically operate on only 750mW of power at maximum access times as fast as 12ns.

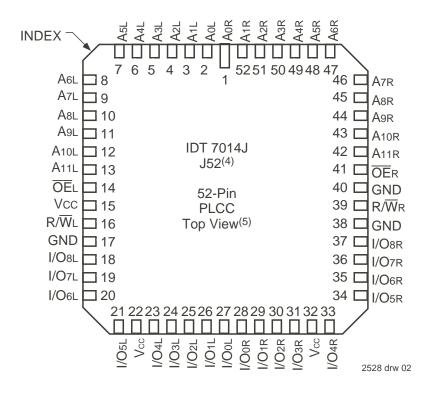
The IDT7014 is packaged in a 52-pin PLCC and a 64-pin thin guad flatpack, (TQFP).

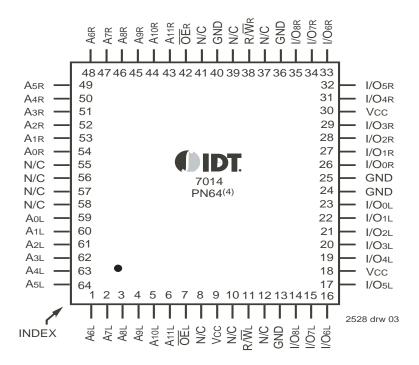
Functional Block Diagram



2528 drw 01

Pin Configuration^(1,2,3)





NOTES:

- 1. All Vcc pins must be connected to power supply.
- 2. All GND pins must be connected to ground supply.
- J52-1 package body is approximately .75 in x .75 in. x .17 in. PN64-1 package body is approximately 14mm x 14mm x 1.4mm.
- 4. This package code is used to reference the package diagram.
- 5. This text does not indicate the orientation of the actual part-marking

Absolute Maximum Ratings (1)

| Symbol | Rating | Commercial & Industrial | Unit |
|----------------------|--|----------------------------|------|
| VTERM ⁽²⁾ | Terminal Voltage with Respect to GND | -0.5 to +7.0 | ٧ |
| VTERM ⁽²⁾ | Terminal Voltage | -0.5 to +Vcc | V |
| TBIAS | Temperature Under Bias | -55 to +125 | °C |
| Tstg | Storage Temperature | -65 to +150 | °C |
| Іоит | DC Output Current | 50 | mA |

NOTES: 2528 tbl 0

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may
 cause permanent damage to the device. This is a stress rating only and functional
 operation of the device at these or any other conditions above those indicated
 in the operational sections of this specification is not implied. Exposure to absolute
 maximum rating conditions for extended periods may affect reliability.
- 2. VTERM must not exceed Vcc + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to \leq 20mA for the period of VTERM \geq Vcc + 10%.

Maximum Operating Temperature and Supply Voltage^(1,2)

| | , ronago | | |
|------------|------------------------|-----|-------------------|
| Grade | Ambient Temperature | GND | Vcc |
| Commercial | 0°C to +70°C | 0V | 5.0V <u>+</u> 10% |
| Industrial | -40°C to +85°C | 0V | 5.0V <u>+</u> 10% |

NOTES:

2528 tbl 02

1. This is the parameter Ta. This is the "instant on" case temperature.

Recommended DC Operating Conditions

| Symbol | Parameter | Min. | Тур. | Max. | Unit |
|--------|--------------------|---------------------|------|--------|------|
| Vcc | Supply Voltage | 4.5 | 5.0 | 5.5 | V |
| GND | Ground | 0 | 0 | 0 | V |
| VIH | Input High Voltage | 2.2 | _ | 6.0(2) | V |
| VIL | Input Low Voltage | -0.5 ⁽¹⁾ | _ | 0.8 | V |

NOTES

2528 tbl 03

- 1. $VIL \ge -1.5V$ for pulse width less than 10ns.
- 2. VTERM must not exceed Vcc + 10%.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range⁽¹⁾ (Vcc = $5.0V \pm 10\%$)

| | | | 7014S | | |
|--------|------------------------|---------------------------------|-------|------|------|
| Symbol | Parameter | Test Conditions | Min. | Max. | Unit |
| ILI | Input Leakage Current | Vcc = 5.5V, $VIN = 0V$ to Vcc | _ | 10 | μΑ |
| llo | Output Leakage Current | Vout = 0V to Vcc | | 10 | μΑ |
| Vol | Output Low Voltage | IoL = +4mA | - | 0.4 | V |
| Vон | Output High Voltage | Iон = -4mA | 2.4 | _ | V |

NOTE:

2528 tbl 04

At Vcc ≤ 2.0V input leakages are undefined.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range (Vcc = 5V ± 10%)

| | | | | _ | 4S12 I Only | - | IS15 Only | |
|--------|--------------------------------|---|---------|------|----------------|------|--------------|------|
| Symbol | Parameter | Test Condition | Version | Тур. | Max | Тур. | Max | Unit |
| lcc | Dynamic Operating | Outputs Open f = fMax ⁽¹⁾ | COM'L S | 160 | 250 | 160 | 250 | mA |
| | Current (Both Ports Active) | I = IMAX** | IND S | _ | _ | _ | _ | |

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| | | | | | _ | 4S20 & Ind | | IS25 Only | |
|--------|--------------------------------|---|--------|----|------|---------------|------|--------------|------|
| Symbol | Parameter | Test Condition | Versio | on | Тур. | Max | Тур. | Max. | Unit |
| lcc | Dynamic Operating | Outputs Open f = fMax ⁽¹⁾ | COM'L | S | 155 | 245 | 150 | 240 | mA |
| | Current (Both Ports Active) | I = IMAX** | IND | S | 155 | 260 | | - | |

2528 tbl 05b

NOTES:

1. At f = fmax, address inputs are cycling at the maximum read cycle of 1/trc using the "AC Test Conditions" input levels of GND to 3V.

AC Test Conditions

| Input Pulse Levels | GND to 3.0V |
|-------------------------------|-------------------|
| Input Rise/Fall Times | 3ns Max. |
| Input Timing Reference Levels | 1.5V |
| Output Reference Levels | 1.5V |
| Output Load | Figures 1,2 and 3 |

2528 tbl 06

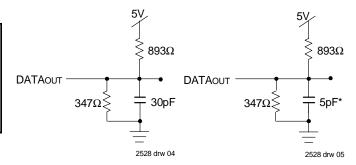


Figure 1. AC Output Test Load.

Figure 2. Output Test Load (for thz, twz, and tow) *Including scope and jig.

Capacitance⁽¹⁾

(TA = +25°C, f = 1.0MHz) TQFP Package Only

| Symbol | Parameter | Conditions ⁽²⁾ | Max. | Unit |
|--------|--------------------|---------------------------|------|------|
| CIN | Input Capacitance | VIN = 3dV | 9 | pF |
| Соит | Output Capacitance | Vout = 3dV | 10 | pF |

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NOTES:

- This parameter is determined by device characteristics but is not production tested.
- 2. 3dv references the interpolated capacitance when the input and output signals swith from 0V to 3V or from 3V to 0V.

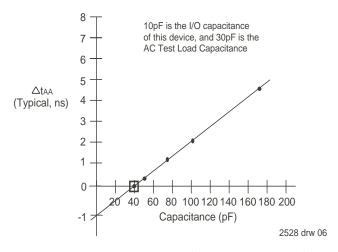


Figure 3. Typical Output Derating (Lumped Capacitive Load).

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage

| | | 7014S12 Com'l Only | | 7014S15 Com'l Only | | |
|------------|-------------------------------------|-----------------------|------|-----------------------|------|------|
| Symbol | Parameter | Min. | Max. | Min. | Max. | Unit |
| READ CYCLE | | | | | | |
| trc | Read Cycle Time | 12 | | 15 | | ns |
| taa | Address Access Time | | 12 | 1 | 15 | ns |
| taoe | Output Enable Access Time | | 8 | | 8 | ns |
| tон | Output Hold from Address Change | 3 | | 3 | | ns |
| tLz | Output Low-Z Time ^(1,2) | 3 | | 3 | | ns |
| tHZ | Output High-Z Time ^(1,2) | _ | 7 | _ | 7 | ns |

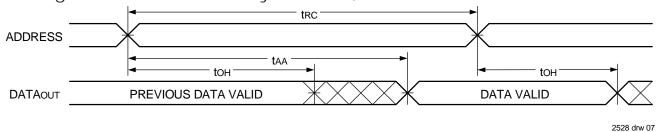
2528 tbl 08a

| | | 7014S20 Com'l & Ind | | 7014S25 Com'l Only | | |
|------------|-------------------------------------|------------------------|------|-----------------------|------|------|
| Symbol | Parameter | Min. | Max. | Min. | Max. | Unit |
| READ CYCLE | | | | | | |
| trc | Read Cycle Time | 20 | | 25 | 1 | ns |
| taa | Address Access Time | | 20 | 1 | 25 | ns |
| taoe | Output Enable Access Time | | 10 | 1 | 12 | ns |
| toн | Output Hold from Address Change | 3 | | 3 | 1 | ns |
| tLz | Output Low-Z Time ^(1,2) | 3 | | 3 | | ns |
| tHZ | Output High-Z Time ^(1,2) | | 9 | _ | 11 | ns |

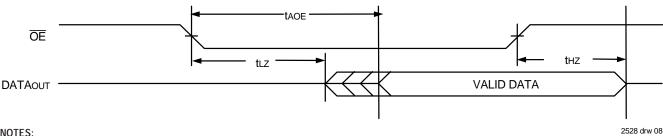
2528 tbl 08b

- Transition is measured 0mV from Low or High-impedance voltage with Output Test Load (Figure 2).
 This parameter is determined by device characterization, but is not production tested.

Timing Waveform of Read Cycle No. 1, Either Side^(1,2)



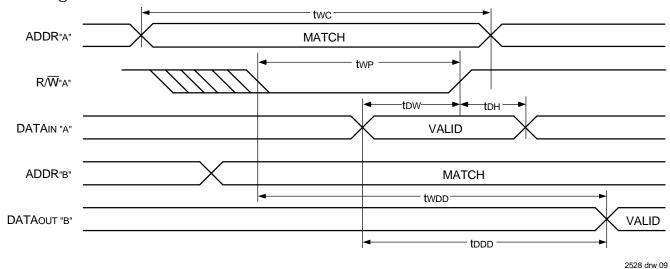
Timing Waveform of Read Cycle No. 2, Either Side^(1, 3)



NOTES:

- 1. $R/\overline{W} = V_{IH}$ for Read Cycles.
- 2. $\overline{OE} = VIL$
- 3. Addresses valid prior to $\overline{\text{OE}}$ transition LOW.

Timing Waveform of Write with Port-to-Port Read^(1,2)



NOTES:

- 1. $R/\overline{W}_B^* = V_{IH}$, read cycle pass through.
- 2. All timing is the same for left and right ports. Port "A" may be either left or right port. Port "B" is opposite from port "A".

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage

| | | 7014S12 Com'l Only | | 7014S15 Com'l Only | | |
|-------------|--|-----------------------|------|-----------------------|------|------|
| Symbol | Parameter | Min. | Max. | Min. | Max. | Unit |
| WRITE CYCLE | | | | | | |
| twc | Write Cycle Time | 12 | _ | 15 | _ | ns |
| taw | Address Valid to End-of-Write | 10 | _ | 14 | | ns |
| tas | Address Set-up Time | 0 | _ | 0 | | ns |
| twp | Write Pulse Width | 10 | _ | 12 | _ | ns |
| twr | Write Recovery Time | 1 | | 1 | _ | ns |
| tow | Data Valid to End-of-Write | 8 | _ | 10 | _ | ns |
| tHZ | Output High-Z Time ^(1,2) | | 7 | _ | 7 | ns |
| tон | Data Hold Time ⁽³⁾ | 0 | | 0 | _ | ns |
| twz | Write Enable to Output in High-Z ^(1,2) | _ | 7 | _ | 7 | ns |
| tow | Output Active from End-of-Write ^(1,2,3) | 0 | _ | 0 | _ | ns |
| twdd | Write Pulse to Data Delay ⁽⁴⁾ | _ | 25 | _ | 30 | ns |
| todo | Write Data Valid to Read Data Delay ⁽⁴⁾ | _ | 22 | _ | 25 | ns |

2528 tbl 09a

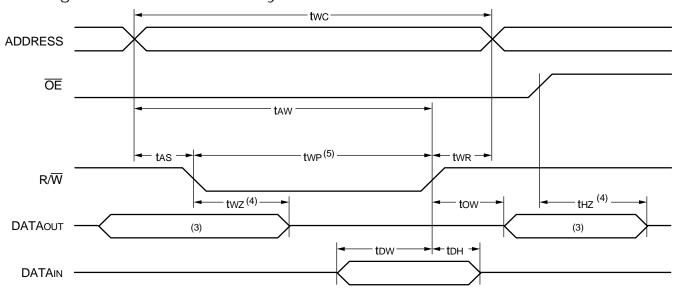
| | | 7014S20 Com'l & Ind | | 7014S25 Com'l Only | | |
|-------------|--|------------------------|------|-----------------------|------|------|
| Symbol | Parameter | Min. | Max. | Min. | Max. | Unit |
| WRITE CYCLE | | | | | | |
| twc | Write Cycle Time | 20 | _ | 25 | _ | ns |
| taw | Address Valid to End-of-Write | 15 | _ | 20 | _ | ns |
| tas | Address Set-up Time | 0 | 1 | 0 | _ | ns |
| twp | Write Pulse Width | 15 | _ | 20 | _ | ns |
| twr | Write Recovery Time | 2 | _ | 2 | _ | ns |
| tow | Data Valid to End-of-Write | 12 | _ | 15 | | ns |
| tHZ | Output High-Z Time ^(1,2) | _ | 9 | _ | 11 | ns |
| tDH | Data Hold Time ⁽³⁾ | 0 | - | 0 | _ | ns |
| twz | Write Enable to Output in High-Z ^(1,2) | | 9 | _ | 11 | ns |
| tow | Output Active from End-of-Write ^(1,2,3) | 0 | _ | 0 | _ | ns |
| twdd | Write Pulse to Data Delay ⁽⁴⁾ | _ | 40 | _ | 45 | ns |
| todo | Write Data Valid to Read Data Delay ⁽⁴⁾ | | 30 | _ | 35 | ns |

NOTES:

- 1. Transition is measured 0mV from Low or High-impedance voltage with Output Test Load (Figure 2).
- 2. This parameter is guaranteed by device characterization, but is not production tested.
- 3. The specification for toH must be met by the device supplying write data to the RAM under all operating conditions. Although toH and tow values will vary over voltage and temperature, the actual toH will always be smaller than the actual tow.
- 4. Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Write With Port-to-Port Read".

2528 tbl 09b

Timing Waveform of Write Cycle^(1,2,3,4,5)



NOTES:

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- 1. R/W must be HIGH during all address transitions.
- 2. twn is measured from R/\overline{W} going HIGH to the end of write cycle.
- 3. During this period, the I/O pins are in the output state, and input signals must not be applied.
- 4. Transition is measured 0mV from the Low or High-impedance voltage with the Output Test Load (Figure 2).
- 5. If \overline{OE} is LOW during a R/ \overline{W} controlled write cycle, the write pulse width must be the larger of two or (twz + tow) to allow the I/O drivers to turn off data to be placed on the bus for the required tow. If \overline{OE} is HIGH during an R/ \overline{W} controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp.

Functional Description

The IDT7014 provides two ports with separate control, address, and I/O pins that permit independent access for reads or writes to any location in memory. It lacks the chip enable feature of CMOS Dual Ports, thus it operates in active mode as soon as power is applied. Each port has its own Output Enable control ($\overline{\text{OE}}$). In the read mode, the port's $\overline{\text{OE}}$ turns on the output drivers when set LOW. The user application should avoid simultaneous write operations to the same memory location. There is no on-chip arbitration circuitry to resolve write priority and partial data from both ports may be written. READ/WRITE conditions are illustrated in Table 1.

Truth Table I - Read/Write Control

| Left or Right Port ⁽¹⁾ | | | |
|-----------------------------------|----|---------|-------------------------------|
| R∕W | ŌĒ | D0-8 | Function |
| L | Х | DATAIN | Data written into memory |
| Н | L | DATAOUT | Data in memory output on port |
| Х | Н | Z | High-impedance outputs |

2528 tbl 10

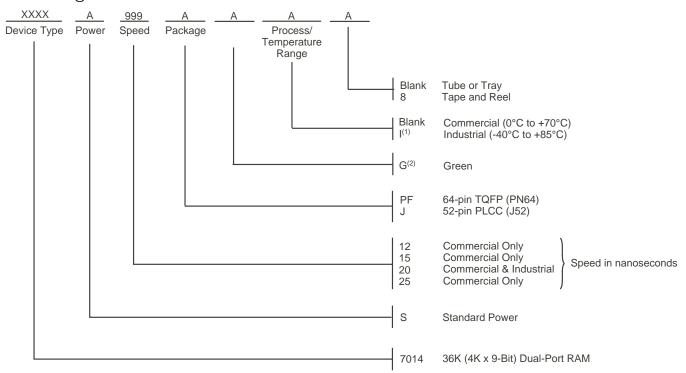
NOTE:

1. AoL - A11L is not equal to AoR - A11R.

'H' = HIGH, 'L' = LOW, 'X' = Don't Care, and 'Z' = HIGH Impedance.

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Ordering Information



NOTES:

Industrial temperature: for other speeds, packages and powers contact your sales office.
 Green parts avaliable. For specific speeds, packages and powers contact your local sales office.

Datasheet Document History

01/06/99: Initiated datasheet document history

Converted to new format

Cosmetic and typographical corrections Added additional notes to pin configurations

Page 2 Added additional notes to Changed drawing format

Page 1 Corrected DSC number

03/10/00: Added Industrial Temperature Ranges and deleted corresponding notes

Replaced IDT logo

Page 1 Made corrections to drawing

Changed ±200mV to 0mV in notes
Page 6 Made changes to drawings

05/19/00: Page 3 Increased storage temperature parameter

Clarified TA parameter

10/16/01: Page 2 Added date revision for pin configuration

Pages 4, 5 & 7 Removed Industrial temp values and column headings for 15 & 25ns speeds from

DC and AC Electrical Characteristics

Page 9 Removed Industrial temp offering from 15 & 25ns ordering information

Added Industrial temp footnote to ordering information

Pages 1 & 9 Replaced ™ logo with ® logo 04/04/06: Page 1 Added green availability to feature

Page 1 Added green availability to features
Page 9 Added green indicator to ordering information

12/11/08: Page 9 Removed "IDT" from orderable part number 08/18/14: Page 9 Added Tape and Reel to Ordering Information

Page 2 & 9 The package codes PN84-1 & J52-1 changed to PN84 & J52 respectively to match standard

package codes

Datasheet Document History (con't)

03/16/16: Page 2 Changed diagram for the PN64 pin configuration by rotating package pin labels and pin

numbers 90 degrees counter clockwise to reflect pin 1 orientation and added pin 1 dot at pin 1 Removed the PN64 chamfer and aligned the top and bottom pin labels in the standard direction

Added the IDT logo to the PN64 pin configurations and changed the text to be in

alignment with new diagram marking specs

 $Removed the \, date \, revision \, indicator \, for \, each \, pin \, configuration$

Updated footnote references for PN64 pin configuration

Page 4 Figuire 3 Typical Output Derating Graph, corrected a typo



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